## nexperia

## **Reliability Monitoring Results**

## Quarters: Q1/2022 to Q4/2022

Based on structural similarity

| Suppli                       | ier  | User Part Number   |                             |           |            |              |
|------------------------------|--|--|-----------------------------|-----------|------------|--------------|
| Nexperia B.V. 74LVCU04AD-Q10 |  |  |                             |           |            |              |
| Part D                       | Description: Hex inverter; u                                       | nbuffered  |                             |           |            |              |
| Pro                          | nction Family: LVC<br>cess family: Sub micron<br>ckage family: SO  |  |                             |           |            |              |
| JESD4                        | 7 Test   | Test Conditions  | Duration                    | # Lots    | # Quantity | #<br>Rejects |
| # 1                          | <b>TEST</b><br>Pre- and Post-Stress<br>Electrical Test             | Tamb = 25 °C   | N/A                         | see below | all parts  | see<br>below |
| # 2                          | <b>PC</b><br>Preconditioning                                       | JESD22-A113<br>MSL 1   | N/A                         | 460       | 29380      | 0            |
| # 5a                         | HTOL EFR<br>High Temperature<br>Operating Life Extrinsic           | JESD22-A108<br>Tj = 150°C<br>V <sub>CCMAX</sub> $\leq$ V $\leq$ 1.2*V <sub>CCMAX</sub> | 48 hours<br>or<br>168 hours | 380       | 56512      | 0            |
| # 5b                         | HTOL IFR<br>High Temperature<br>Operating Life Intrinsic           | JESD22-A108<br>Tj = 150°C<br>$V_{CCMAX} \le V \le 1.2*V_{CCMAX}$                       | ≥500 hours                  | 155       | 11552      | 0            |
| # 7                          | TC<br>Temperature Cycling  | JESD22-A104<br>-65 °C to 150°C   | ≥500 cycles                 | 69        | 17630      | 4            |
| # 9                          | uHAST / HAST<br>unbiased or biased High<br>Accelerated Stress Test | JESD22-A101<br>Tamb = 130 °C,<br>RH = 85%, V = V <sub>CCMAX</sub>                      | 96 hours                    | 202       | 11750      | 0            |

## **Calculation of PPM, FIT and MTTF**

Test considered for PPM calculation: High Temperature Operating LifeTest Extrinsic (HTOL EFR, Test # 5a above) Test considered for FIT and MTTF calculations: High Temperature Operating LifeTest Intrinsic(HTOL IFR, Test # 5b above)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| Product<br>Family | Package<br>Family | Quantity | Rejects | Extrinsic<br>Failure Rate (PPM) | Intrinsic<br>Failure Rate (FIT) | MTTF (hrs) |
|-------------------|-------------------|----------|---------|---------------------------------|---------------------------------|------------|
| LVC               | SO                | 11552    | 0       | 17                              | 0.4                             | 2.77 E+09  |

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